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10/534,119 Examiner

Linh V. Nguyen

Applicant(s)/Patent	und	е
Reexamination		

IHS ET AL.

Art Unit

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	SEARCHED		
Class	Subclass	Date	Examiner
341	118,120, 143,155	2/20/2007	LN
		7,460	•
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
1	xt searched- rintout	2/20/2007	LN

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